Vincotech

10-FY07HVA075S502-L985F18
10-PY07HVA075S502-L985F18Y

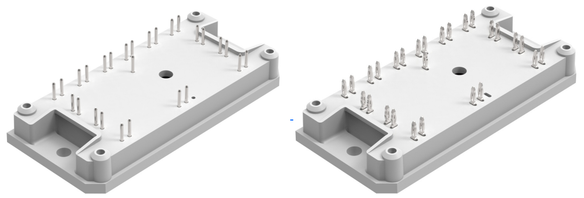
datasheet

***flow*PACK 1 H6.5** — **650 V / 75 A**

Features

- Innovative H6.5 topology
- Fast IGBT S5
- Optimized for wide range of load conditions
- LVRT (Low voltage ride through) capability
- Integrated temperature sensor

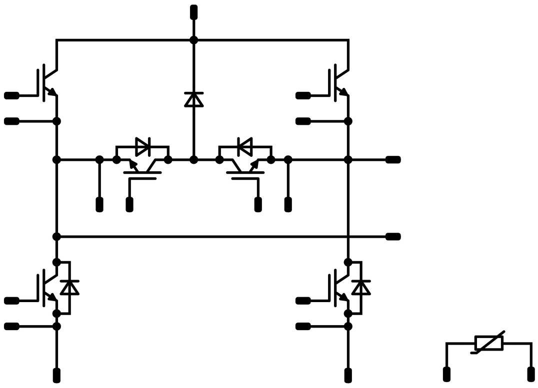
flow 1 12 mm housing



Target applications

- Solar Inverters
- Special Application

Schematic



Types

- 10-FY07HVA075S502-L985F18
- 10-PY07HVA075S502-L985F18Y

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit
Low Buck Switch / High Buck Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current	I_C	$T_j = T_{jmax}$	T_s = 80 °C	58	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		225	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	86	W
Gate-emitter voltage	V_{GES}			±20	V
Maximum junction temperature	T_{jmax}			175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit
Buck Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$	T_s = 80 °C	47	A
Repetitive peak forward current	I_{FRM}			100	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	63	W
Maximum junction temperature	T_{jmax}			175	°C
Boost Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current	I_C	$T_j = T_{jmax}$	T_s = 80 °C	58	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		225	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	86	W
Gate-emitter voltage	V_{GES}			±20	V
Maximum junction temperature	T_{jmax}			175	°C
Low Boost Diode / High Boost Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$	T_s = 80 °C	47	A
Repetitive peak forward current	I_{FRM}			100	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	63	W
Maximum junction temperature	T_{jmax}			175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit
Module Properties					
Thermal Properties					
Storage temperature	T_{stg}			-40…+125	°C
Operation temperature under switching condition	T_{jop}			-40…(T_{jmax} - 25)	°C
Isolation Properties					
Isolation voltage	V_{isol}	DC Test Voltage*	t_p = 2 s	6000	V
		AC Voltage	t_p = 1 min	2500	V
Creepage distance				min. 12,7	mm
Clearance		Solder pin version		7,85	mm
		Press-fit pin version		8,3	mm
Comparative Tracking Index	CTI			> 200	

*100 % tested in production

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Low Buck Switch / High Buck Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE} = V_{CE}$			0,00075	25	3,2	4	4,8	V
Collector-emitter saturation voltage	V_{CEsat}		15		75	25 125 150		1,56 1,56 1,59	1,75	V
Collector-emitter cut-off current	I_{CES}		0	650		25			50	µA
Gate-emitter leakage current	I_{GES}		20	0		25			100	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f= 1 Mhz	0	25		25		4500		pF
Output capacitance	C_{oes}							130		
Reverse transfer capacitance	C_{res}							17		
Gate charge	Q_g		15	520	75	25		164		nC
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,10		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 4 Ω R_{goff} = 4 Ω	-5 / 15	350	75	25 125 150		31 31 31		ns
Rise time	t_r					25 125 150		10 10 11		
Turn-off delay time	$t_{d(off)}$					25 125 150		110 126 132		
Fall time	t_f					25 125 150		10 25 32		
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 2,2 µC Q_{rFWD} = 4 µC Q_{rFWD} = 4,7 µC				25 125 150		0,450 0,701 0,758		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,457 0,875 1,02		

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	Unit
Buck Diode										
Static										
Forward voltage	V_F				50	25 125 150		1,50 1,44 1,42	1,92	V
Reverse leakage current	I_R			650		25			2,65	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,50		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt = 5329 A/µs di/dt = 8023 A/µs di/dt = 7260 A/µs	-5 / 15	350	75	25 125 150		86 110 117		A
Reverse recovery time	t_{rr}					25 125 150		55 87 101		ns
Recovered charge	Q_r					25 125 150		2,18 4,04 4,70		µC
Reverse recovered energy	E_{rec}					25 125 150		0,381 0,838 1,02		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		5984 4040 4174		A/µs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	Unit
Boost Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE} = V_{CE}$			0,00075	25	3,2	4	4,8	V
Collector-emitter saturation voltage	V_{CEsat}		15		75	25 125 150		1,56 1,56 1,59	1,75	V
Collector-emitter cut-off current	I_{CES}		0	650		25			50	µA
Gate-emitter leakage current	I_{GES}		20	0		25			100	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f= 1 Mhz	0	25		25		4500		pF
Output capacitance	C_{oes}	f= 1 Mhz	0	25		25		130		pF
Reverse transfer capacitance	C_{res}	f= 1 Mhz	0	25		25		17		pF
Gate charge	Q_g		15	520	75	25		164		nC
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,10		K/W
Dynamic (T21, D12)										
Turn-on delay time	$t_{d(on)}$	R_{goff} = 4 Ω R_{gon} = 4 Ω	±15	350	76	25 125 150		60 62 60		ns
Rise time	t_r	R_{goff} = 4 Ω R_{gon} = 4 Ω	±15	350	76	25 125 150		11 10 11		ns
Turn-off delay time	$t_{d(off)}$	R_{goff} = 4 Ω R_{gon} = 4 Ω	±15	350	76	25 125 150		88 106 109		ns
Fall time	t_f	R_{goff} = 4 Ω R_{gon} = 4 Ω	±15	350	76	25 125 150		12 17 22		ns
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 2,2 µC Q_{rFWD} = 4,1 µC Q_{rFWD} = 4,7 µC	±15	350	76	25 125 150		0,661 0,904 0,986		mWs
Turn-off energy (per pulse)	E_{off}		±15	350	76	25 125 150		0,604 1,04 1,11		mWs

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Low Boost Diode										
Static										
Forward voltage	V_F				50	25 125 150		1,50 1,44 1,42	1,92	V
Reverse leakage current	I_R			650		25			2,65	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,50		K/W
Dynamic (T21, D12)										
Peak recovery current	I_{RRM}	di/dt = 6510 A/µs di/dt = 4900 A/µs di/dt = 6125 A/µs	±15	350	76	25 125 150		83 93 94		A
Reverse recovery time	t_{rr}					25 125 150		59 100 117		ns
Recovered charge	Q_r					25 125 150		2,18 4,08 4,73		µC
Reverse recovered energy	E_{rec}					25 125 150		0,470 0,935 1,10		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		5969 1181 1324		A/µs

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Boost Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE} = V_{CE}$			0,00075	25	3,2	4	4,8	V
Collector-emitter saturation voltage	V_{CEsat}		15		75	25 125 150		1,56 1,56 1,59	1,75	V
Collector-emitter cut-off current	I_{CES}		0	650		25			50	µA
Gate-emitter leakage current	I_{GES}		20	0		25			100	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f= 1 Mhz	0	25		25		4500		pF
Output capacitance	C_{oes}							130		
Reverse transfer capacitance	C_{res}							17		
Gate charge	Q_g		15	520	75	25		164		nC
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,10		K/W
Dynamic (T21, D20)										
Turn-on delay time	$t_{d(on)}$	R_{goff} = 4 Ω R_{gon} = 4 Ω	±15	350	76	25 125 150		65 64 66		ns
Rise time	t_r					25 125 150		12 11 13		
Turn-off delay time	$t_{d(off)}$					25 125 150		87 105 110		
Fall time	t_f					25 125 150		14 21 31		
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 2,1 µC Q_{rFWD} = 4 µC Q_{rFWD} = 4,5 µC				25 125 150		0,527 0,873 0,855		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,733 1,04 1,29		

Characteristic Values

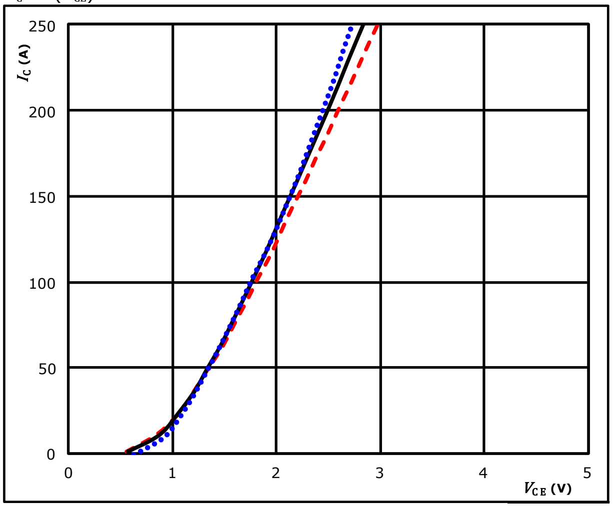
Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_{F} [V]	I_{C} [A] I_{D} [A] I_{F} [A]	T_{j} [°C]	Min	Typ	Max	
High Boost Diode										
Static										
Forward voltage	V_{F}				50	25 125 150		1,50 1,44 1,42	1,92	V
Reverse leakage current	I_{R}			650		25			2,65	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j\text{-}s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,50		K/W
Dynamic (T21, D20)										
Peak recovery current	I_{RRM}					25 125 150		71 92 92		A
Reverse recovery time	t_{rr}					25 125 150		57 105 113		ns
Recovered charge	Q_{r}	di/dt = 6622 A/µs di/dt = 6272 A/µs di/dt = 6687 A/µs	±15	350	76	25 125 150		2,14 4,02 4,51		µC
Reverse recovered energy	E_{rec}					25 125 150		0,629 1,05 1,27		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		1089 1422 1342		A/µs
Thermistor										
Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$\Delta_{R/R}$	R_{100} = 1484 Ω				100	-5		5	%
Power dissipation	P					25		5		mW
Power dissipation constant						25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±1 %				25		3962		K
B-value	$B_{(25/100)}$	Tol. ±1 %				25		4000		K
Vincotech NTC Reference									I	

Low Buck Switch / High Buck Switch Characteristics

figure 1. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

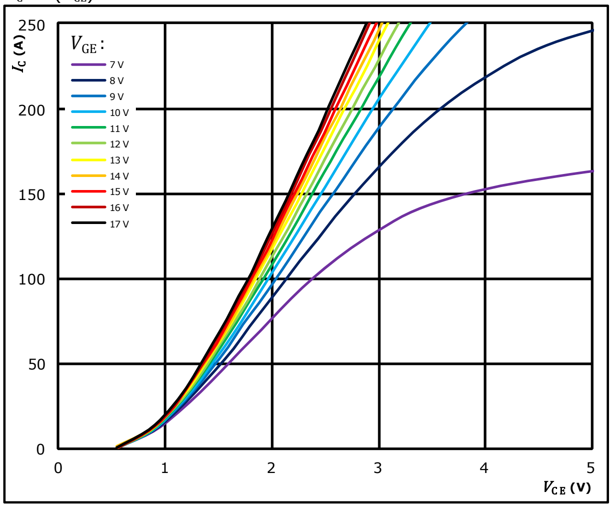


t_p =	250	µs		25 °C	dotted blue
V_{GE} =	15	V	T_j:	125 °C	solid black
				150 °C	dashed red

figure 2. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

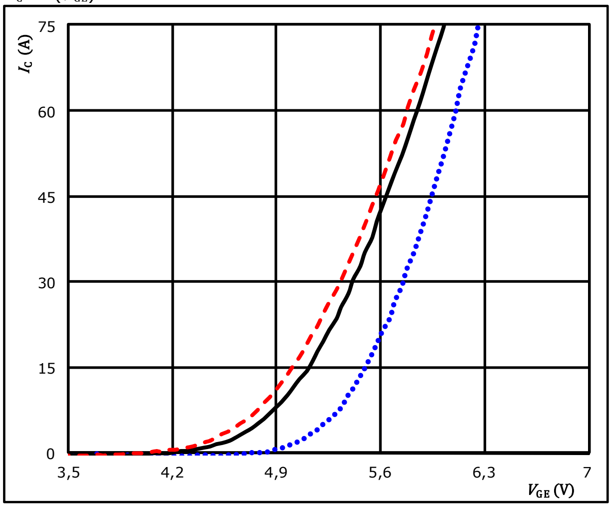


t_p = 250 µs
T_j = 150 °C
V_{GE} from 7 V to 17 V in steps of 1 V

figure 3. **IGBT**

Typical transfer characteristics

$I_C = f(V_{GE})$

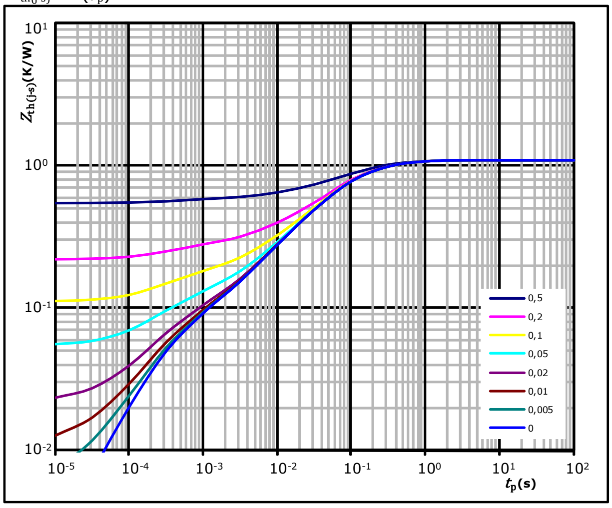


t_p =	100	µs		25 °C	dotted blue
V_{CE} =	10	V	T_j:	125 °C	solid black
				150 °C	dashed red

figure 4. **IGBT**

Transient thermal impedance as function of pulse duration

$Z_{th(j\text{-}s)} = f(t_p)$



D = t_p / T
$R_{th(j\text{-}s)}$ = 1,10 K/W

IGBT thermal model values

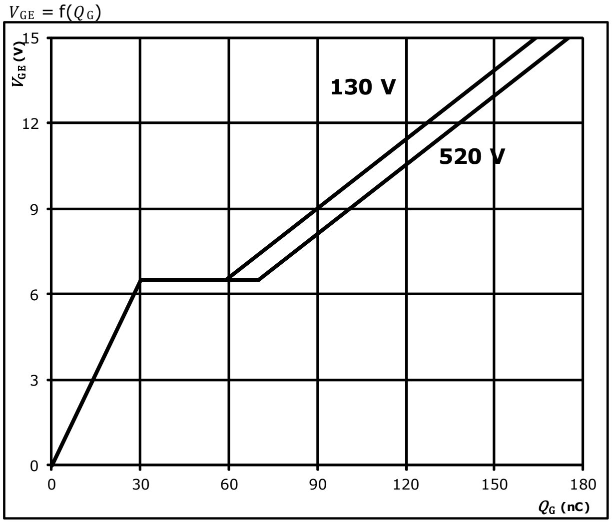
R (K/W)	τ (s)
2,16E-01	4,05E-01
6,30E-01	6,87E-02
1,62E-01	1,13E-02
3,68E-02	2,51E-03
6,02E-02	3,09E-04

Low Buck Switch / High Buck Switch Characteristics

figure 5. IGBT

Gate voltage vs gate charge

$V_{GE} = f(Q_G)$

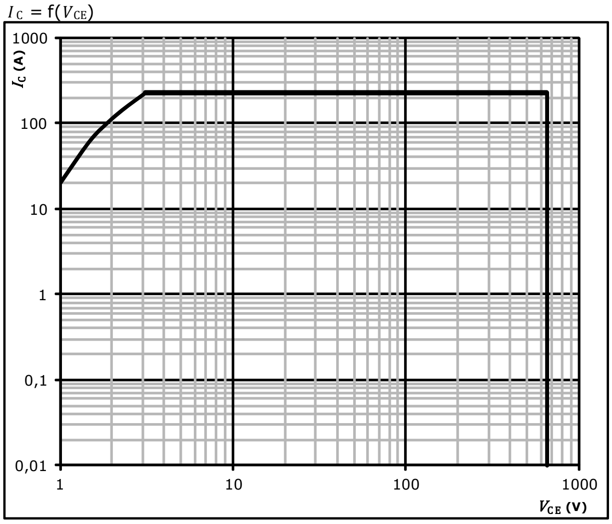


I_C = 75 A

figure 6. IGBT

Safe operating area

$I_C = f(V_{CE})$



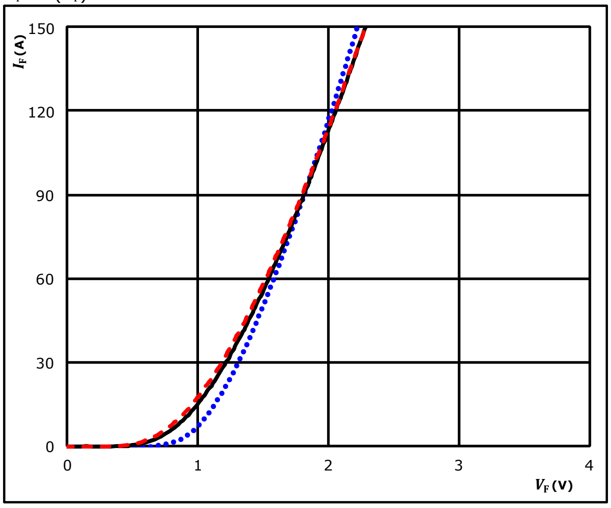
D =	single pulse	
T_s =	80	ºC
V_{GE} =	±15	V
T_j =	T_{jmax}	

Buck Diode Characteristics

figure 1. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



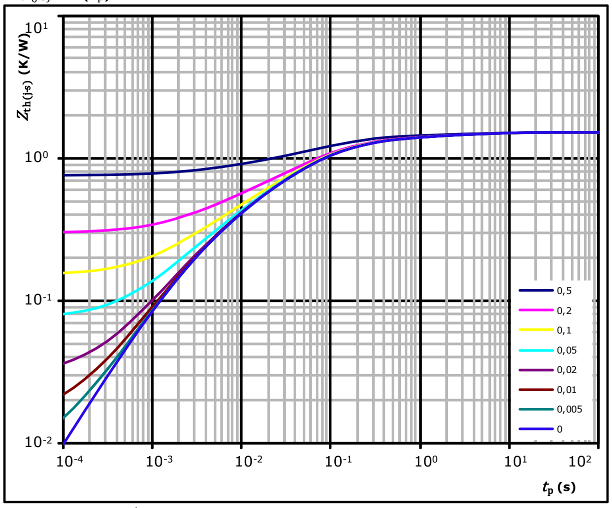
t_p = 250 µs

T_j: 25 °C; 125 °C; 150 °C

figure 2. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,50 K/W

FWD thermal model values

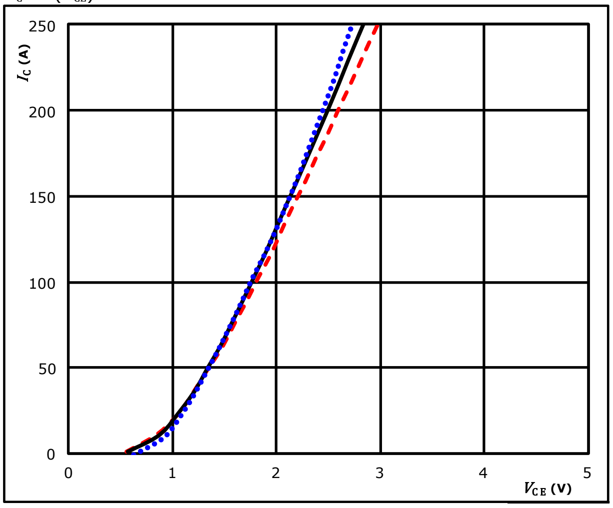
R (K/W)	τ (s)
1,03E-01	4,73E+00
2,05E-01	5,53E-01
6,39E-01	8,31E-02
3,39E-01	2,02E-02
1,71E-01	4,42E-03
4,45E-02	1,30E-03

Boost Switch Characteristics

figure 1. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

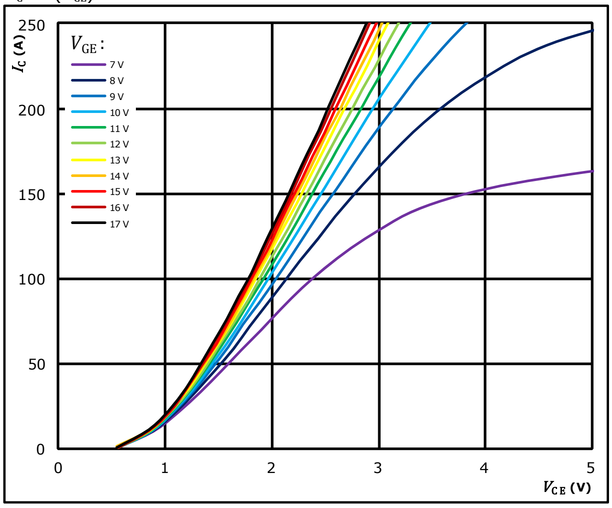


t_p =	250	µs		25 °C	
V_{GE} =	15	V	T_j:	125 °C	
				150 °C	

figure 2. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$



t_p = 250 µs

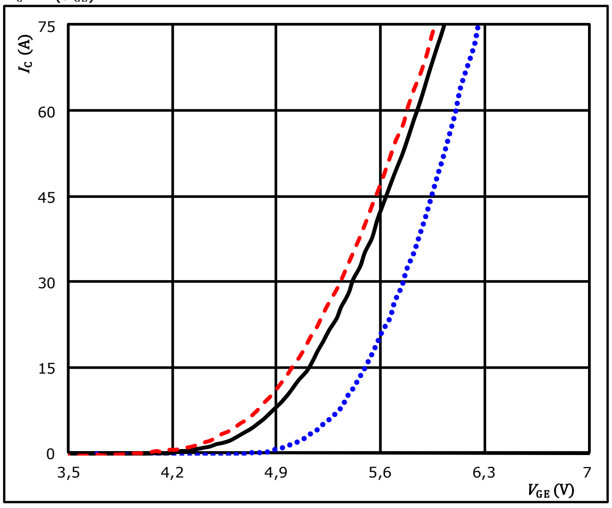
T_j = 150 °C

V_{GE} from 7 V to 17 V in steps of 1 V

figure 3. **IGBT**

Typical transfer characteristics

$I_C = f(V_{GE})$

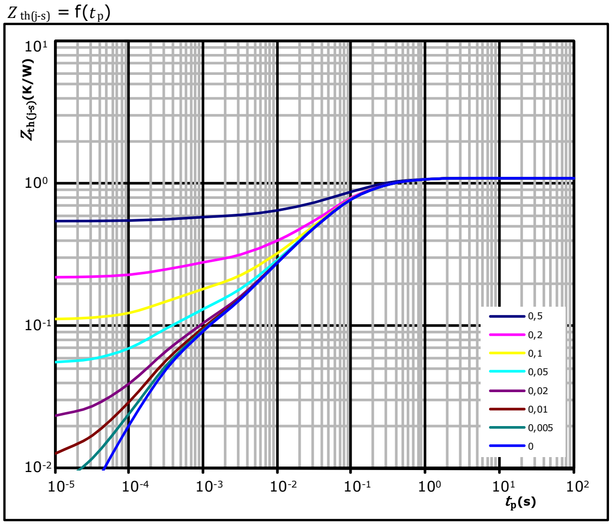


t_p =	100	µs		25 °C	
V_{CE} =	10	V	T_j:	125 °C	
				150 °C	

figure 4. **IGBT**

Transient thermal impedance as function of pulse duration

$Z_{th(j-s)} = f(t_p)$



D = t_p / T

$R_{th(j-s)}$ = 1,10 K/W

IGBT thermal model values

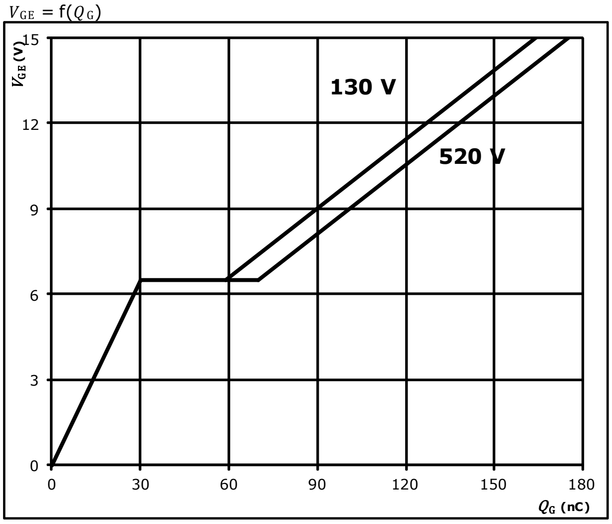
R (K/W)	τ (s)
2,16E-01	4,05E-01
6,30E-01	6,87E-02
1,62E-01	1,13E-02
3,68E-02	2,51E-03
6,02E-02	3,09E-04

Boost Switch Characteristics

figure 5. **IGBT**

Gate voltage vs gate charge

$V_{GE} = f(Q_G)$

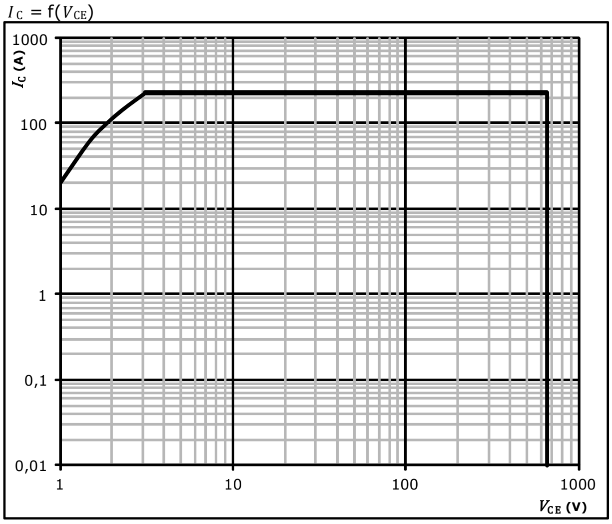


I_C= 75 A

figure 6. **IGBT**

Safe operating area

$I_C = f(V_{CE})$



D =	single pulse	
T_s =	80	ºC
V_{GE} =	±15	V
T_j =	T_{jmax}	

Vincotech

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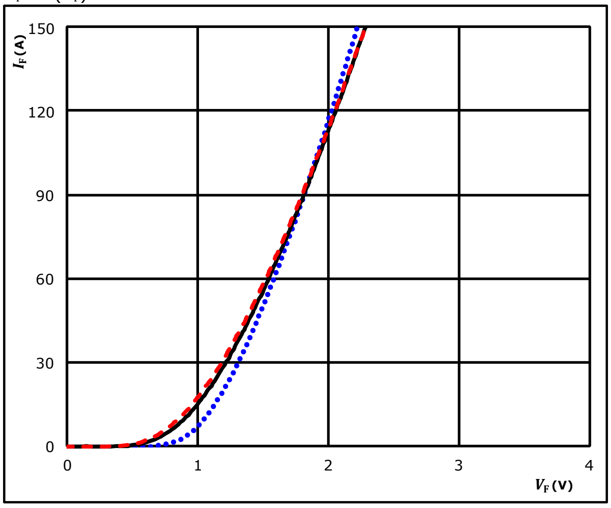
datasheet

Low Boost Diode Characteristics

figure 1. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



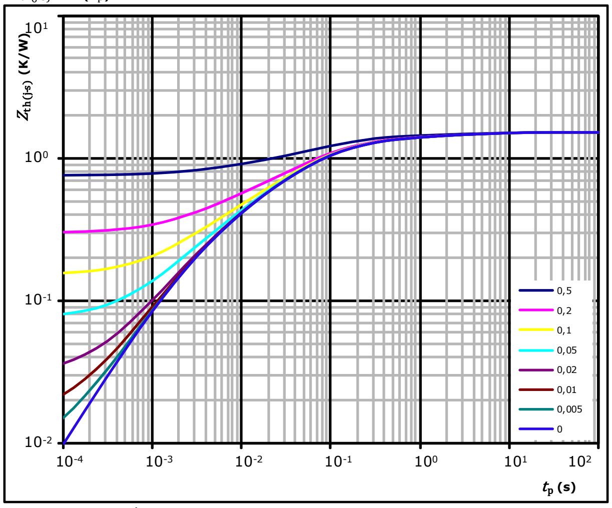
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 2. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,50 K/W

FWD thermal model values

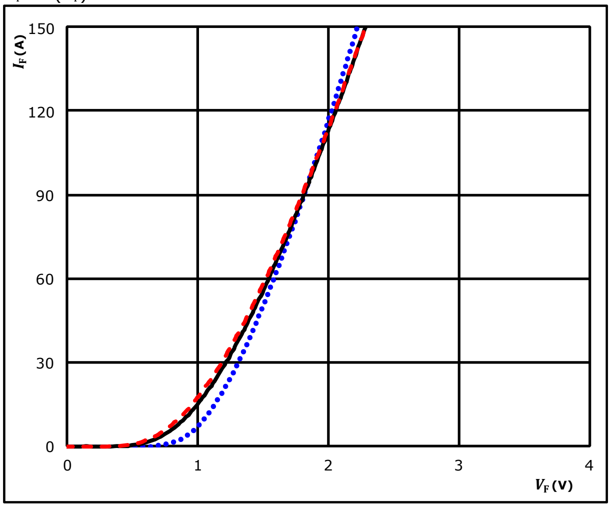
R (K/W)	τ (s)
1,03E-01	4,73E+00
2,05E-01	5,53E-01
6,39E-01	8,31E-02
3,39E-01	2,02E-02
1,71E-01	4,42E-03
4,45E-02	1,30E-03

High Boost Diode Characteristics

figure 1. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



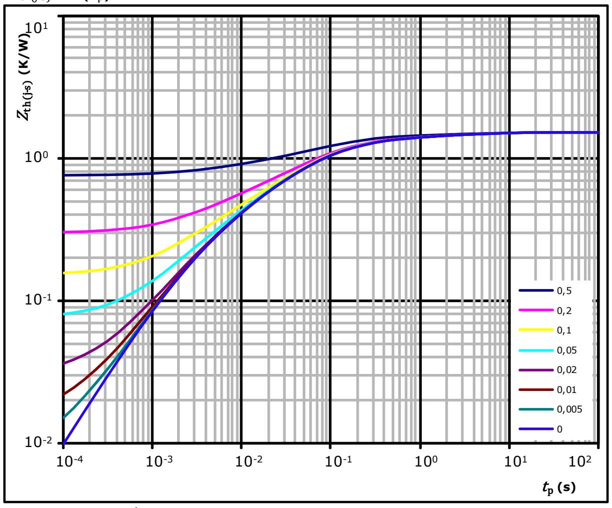
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 2. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,50 K/W

FWD thermal model values

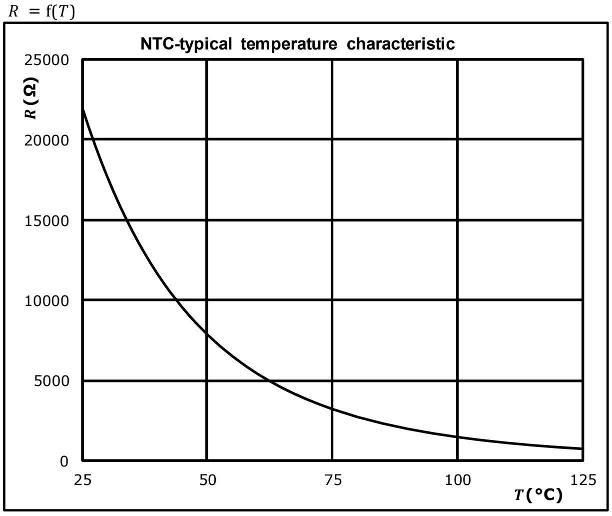
R (K/W)	τ (s)
1,03E-01	4,73E+00
2,05E-01	5,53E-01
6,39E-01	8,31E-02
3,39E-01	2,02E-02
1,71E-01	4,42E-03
4,45E-02	1,30E-03

Thermistor Characteristics

figure 1. **Thermistor**

Typical NTC characteristic as a function of temperature

$R = f(T)$

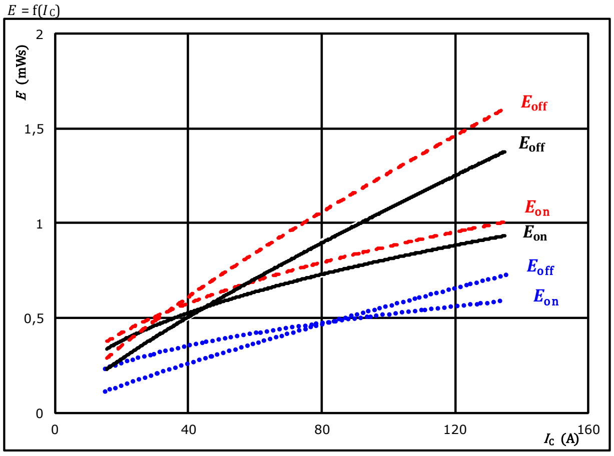


Low Buck / High Buck Switching Characteristics

figure 1. IGBT

Typical switching energy losses as a function of collector current

$E = f(I_C)$



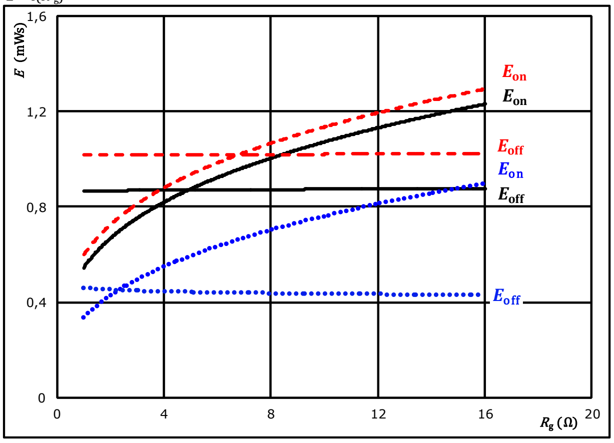
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	-5 / 15	V		125 °C
R_{gon} =	4	Ω		150 °C
R_{goff} =	4	Ω		

figure 2. IGBT

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



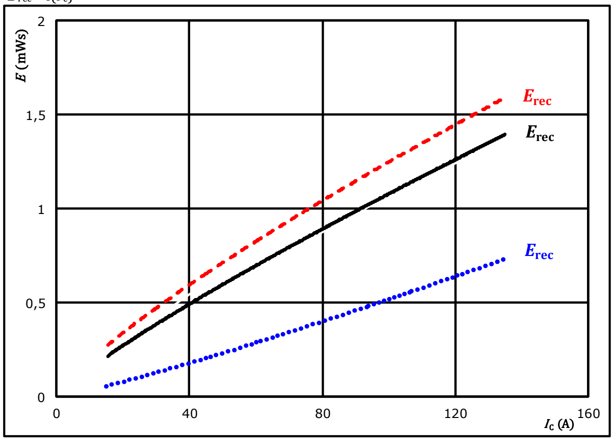
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	-5 / 15	V		125 °C
I_C =	75	A		150 °C

figure 3. FWD

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



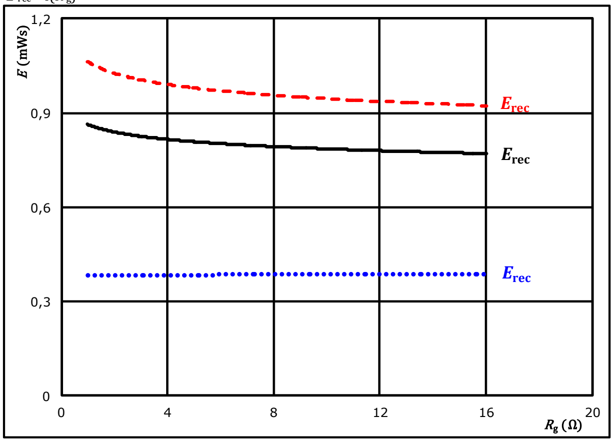
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	-5 / 15	V		125 °C
R_{gon} =	4	Ω		150 °C

figure 4. FWD

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

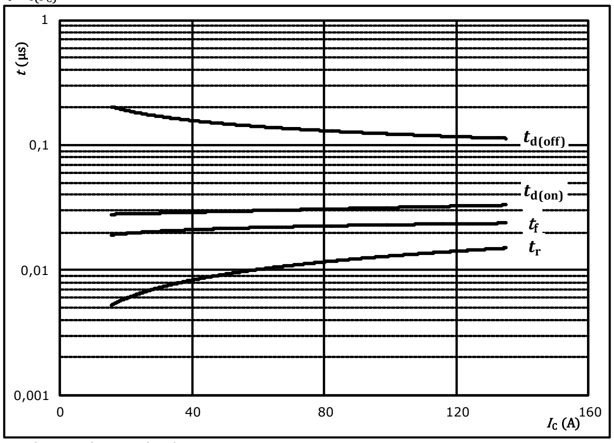
V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	-5 / 15	V		125 °C
I_C =	75	A		150 °C

Low Buck / High Buck Switching Characteristics

figure 5. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



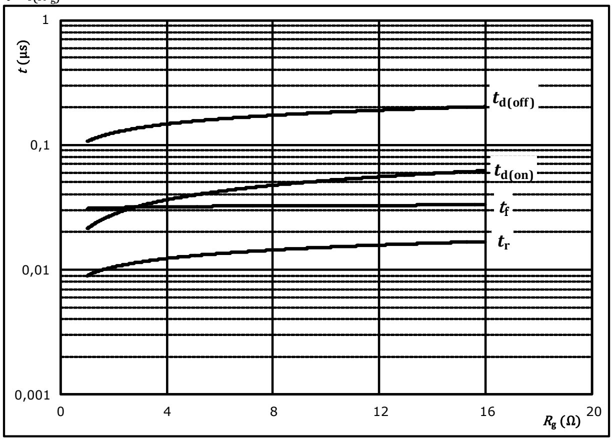
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	-5 / 15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

figure 6. **IGBT**

Typical switching times as a function of gate resistor

$t = f(R_g)$



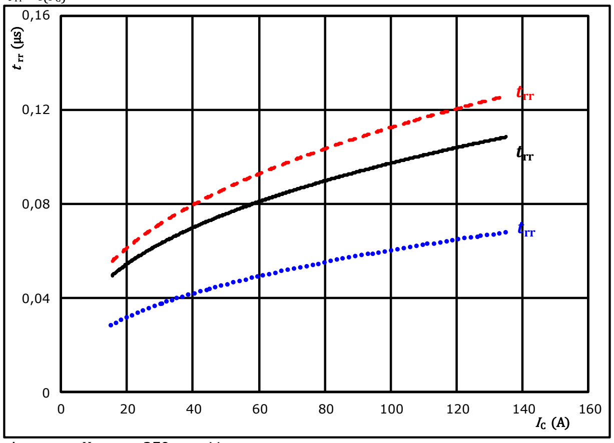
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	-5 / 15	V
I_C =	75	A

figure 7. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$

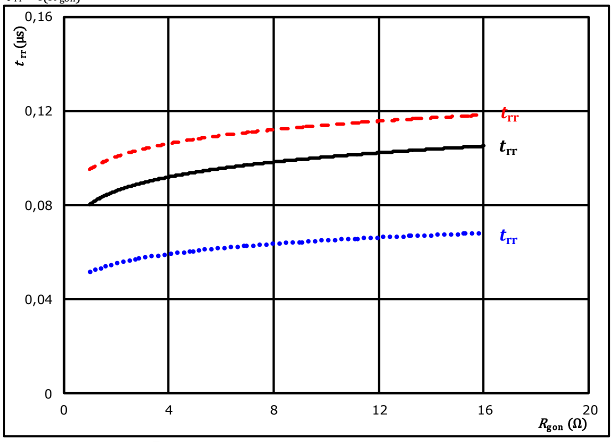


At					
V_{CE} =	350	V		25 °C	dotted blue
V_{GE} =	-5 / 15	V	T_j:	125 °C	solid black
R_{gon} =	4	Ω		150 °C	dashed red

figure 8. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



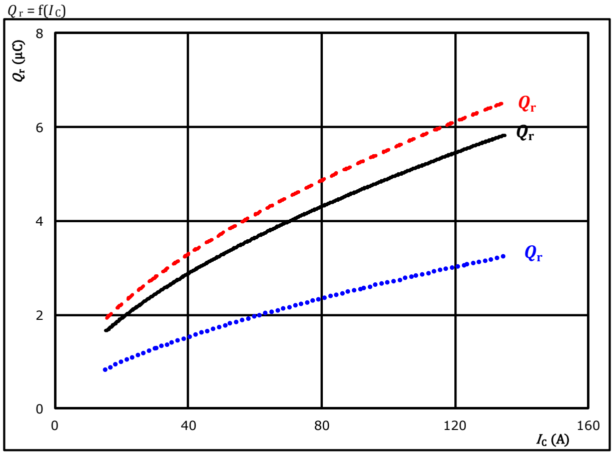
At					
V_{CE} =	350	V		25 °C	dotted blue
V_{GE} =	-5 / 15	V	T_j:	125 °C	solid black
I_C =	75	A		150 °C	dashed red

Low Buck / High Buck Switching Characteristics

figure 9. **FWD**

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$

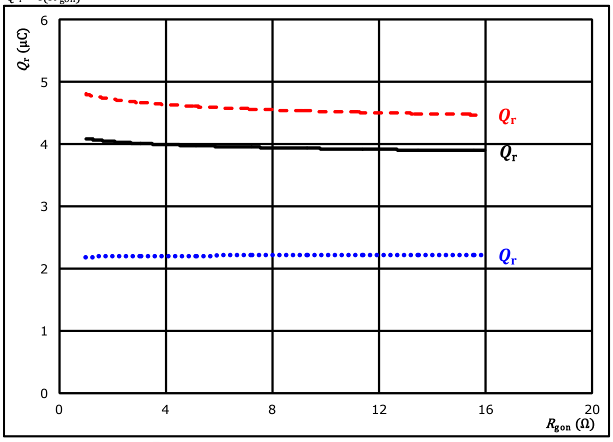


At						
V_{CE} =	350	V		25 °C	
V_{GE} =	-5 / 15	V	T_j:	125 °C	
R_{gon} =	4	Ω		150 °C	

figure 10. **FWD**

Typical recovered charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$

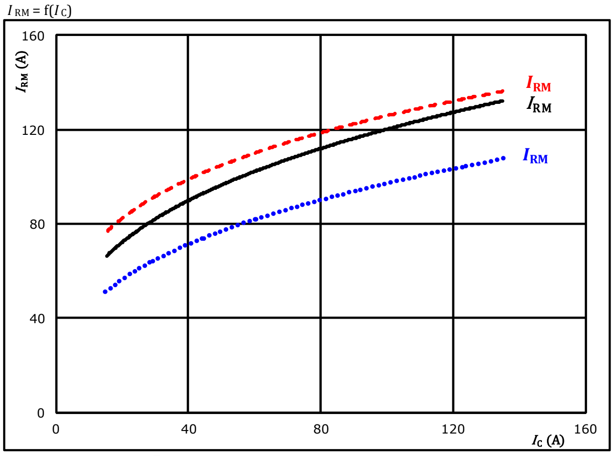


At						
V_{CE} =	350	V		25 °C	
V_{GE} =	-5 / 15	V	T_j:	125 °C	
I_C =	75	A		150 °C	

figure 11. **FWD**

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$

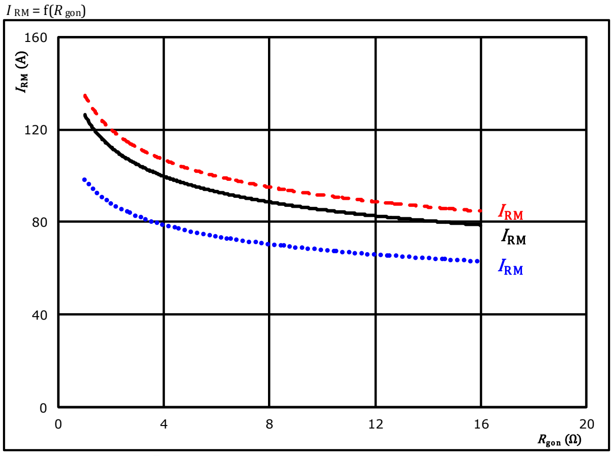


At						
V_{CE}:	350	V		25 °C	
V_{GE} =	-5 / 15	V	T_j:	125 °C	
R_{gon} =	4	Ω		150 °C	

figure 12. **FWD**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



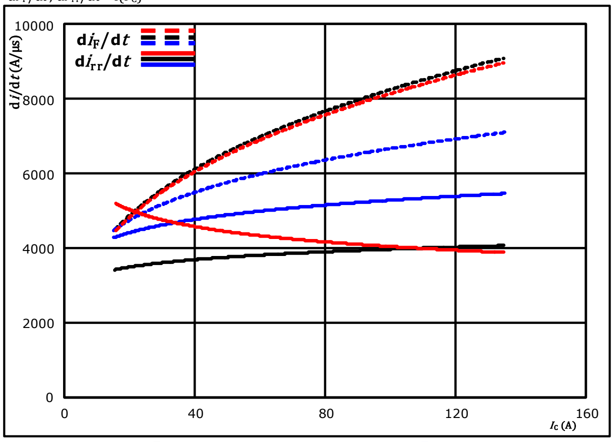
At						
V_{CE} =	350	V		25 °C	
V_{GE} =	-5 / 15	V	T_j:	125 °C	
I_C =	75	A		150 °C	

Low Buck / High Buck Switching Characteristics

figure 13. FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, $di_{rr}/dt = f(I_C)$

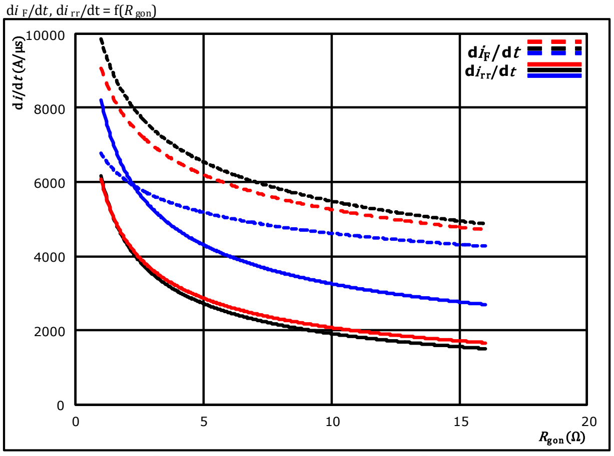


At					
V_{CE} =	350	V		25	°C
V_{GE} =	-5 / 15	V	T_j:	125	°C
R_{gon} =	4	Ω		150	°C

figure 14. FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

di_F/dt, $di_{rr}/dt = f(R_{gon})$

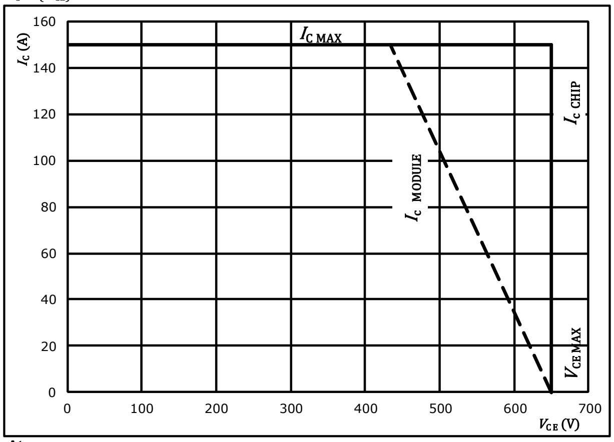


At					
V_{CE} =	350	V		25	°C
V_{GE} =	-5 / 15	V	T_j:	125	°C
I_C =	75	A		150	°C

figure 15. IGBT

Reverse bias safe operating area

$I_C = f(V_{CE})$



At		
T_j =	175	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

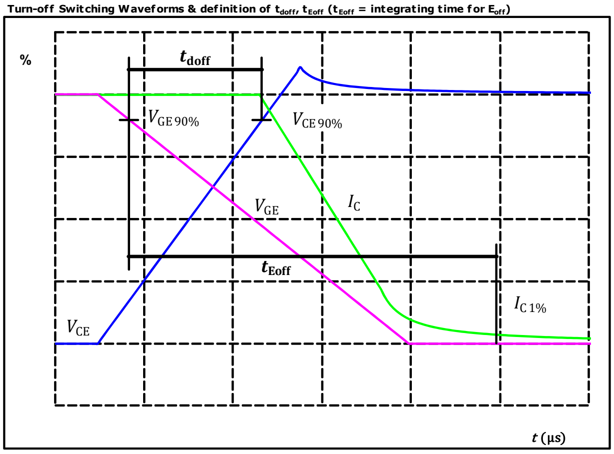
Low Buck / High Buck Switching Definitions

General conditions

T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

figure 1. **IGBT**

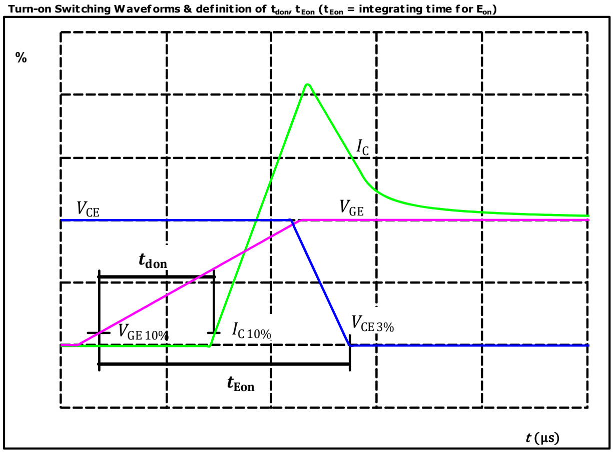
Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff} (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%)$ =	-5	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_{doff} =	126	ns

figure 2. **IGBT**

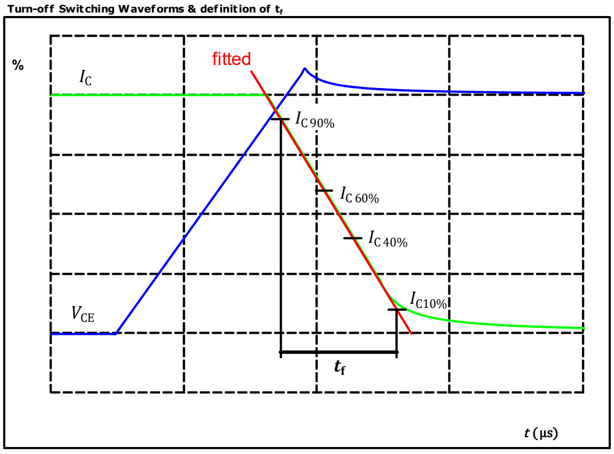
Turn-on Switching Waveforms & definition of t_{don}, t_{Eon} (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%)$ =	-5	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_{don} =	31	ns

figure 3. **IGBT**

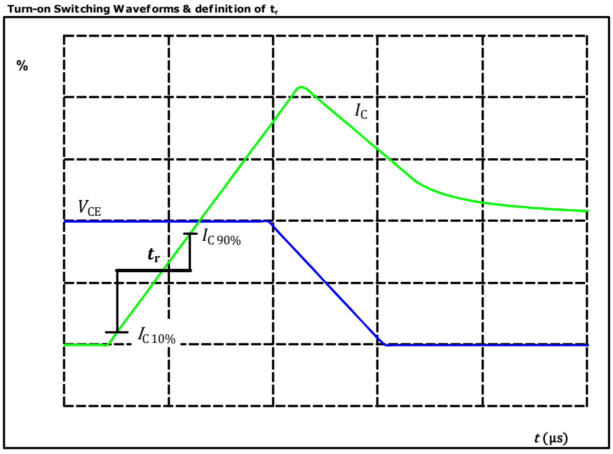
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_f =	25	ns

figure 4. **IGBT**

Turn-on Switching Waveforms & definition of t_r

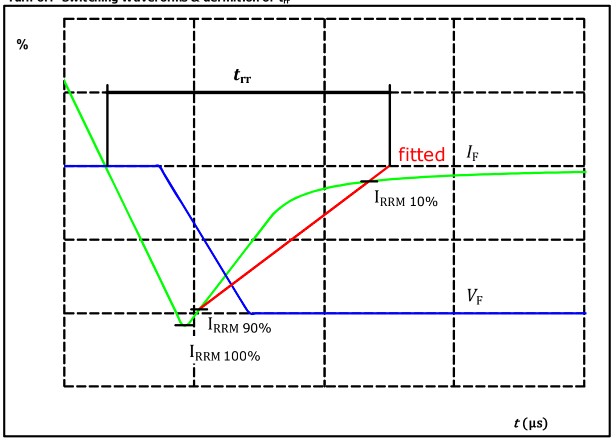


$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_r =	10	ns

Low Buck / High Buck Switching Characteristics

figure 5. **FWD**

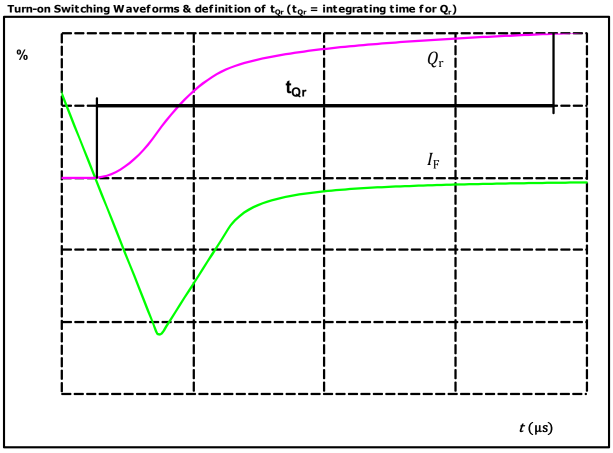
Turn-off Switching Waveforms & definition of t_{rr}



V_F (100%) =	350	V
I_F (100%) =	75	A
I_{RRM} (100%) =	110	A
t_{rr} =	87	ns

figure 6. **FWD**

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



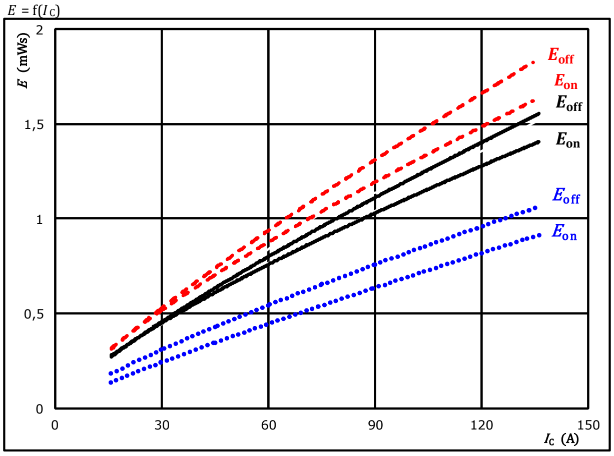
I_F (100%) =	75	A
Q_r (100%) =	4,04	µC

Low Boost Switching Characteristics

figure 1. IGBT

Typical switching energy losses as a function of collector current

$E = f(I_C)$



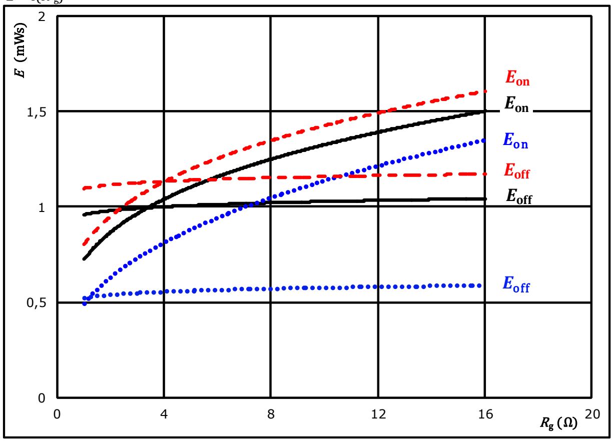
With an inductive load at

			T_j:		
V_{CE} =	350	V		25 °C	blue dotted
V_{GE} =	±15	V		125 °C	black solid
R_{gon} =	4	Ω		150 °C	red dashed
R_{goff} =	4	Ω			

figure 2. IGBT

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



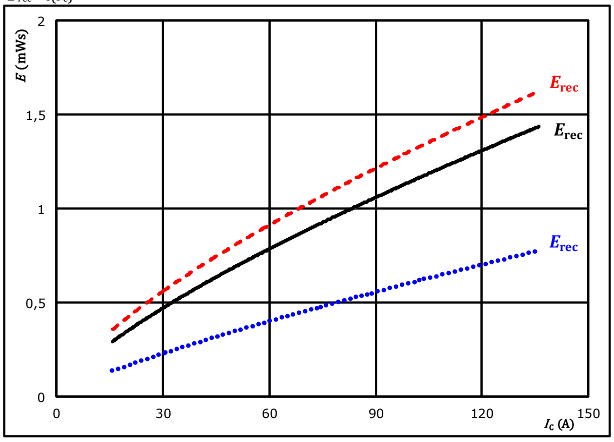
With an inductive load at

			T_j:		
V_{CE} =	350	V		25 °C	blue dotted
V_{GE} =	±15	V		125 °C	black solid
I_C =	76	A		150 °C	red dashed

figure 3. FWD

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_c)$



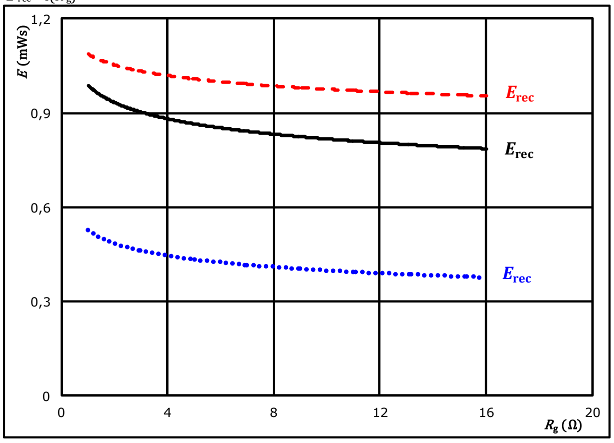
With an inductive load at

			T_j:		
V_{CE} =	350	V		25 °C	blue dotted
V_{GE} =	±15	V		125 °C	black solid
R_{gon} =	4	Ω		150 °C	red dashed

figure 4. FWD

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

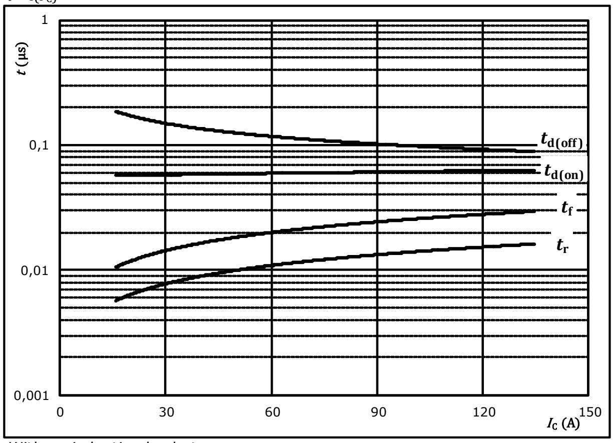
			T_j:		
V_{CE} =	350	V		25 °C	blue dotted
V_{GE} =	±15	V		125 °C	black solid
I_C =	76	A		150 °C	red dashed

Low Boost Switching Characteristics

figure 5. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



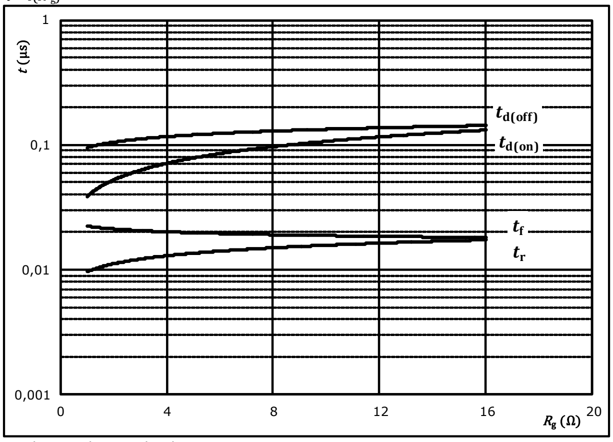
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

figure 6. **IGBT**

Typical switching times as a function of gate resistor

$t = f(R_g)$



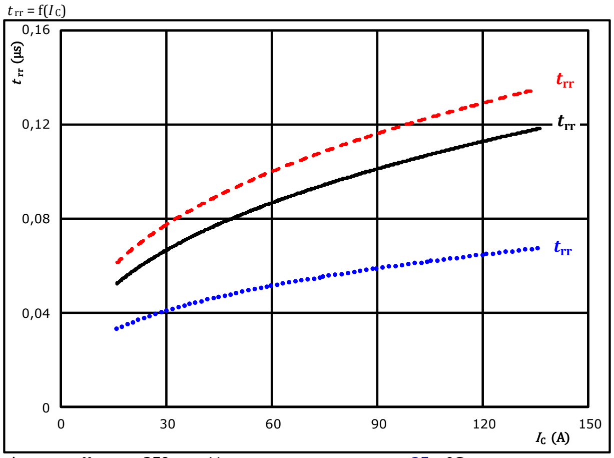
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	76	A

figure 7. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$

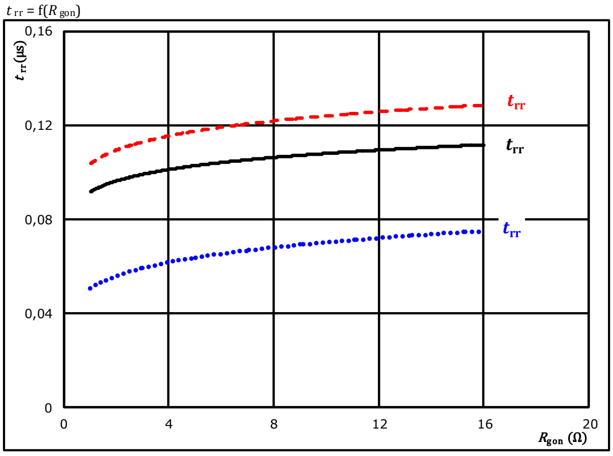


At					
V_{CE}=	350	V		25 °C	•••••••••••••
V_{GE} =	±15	V	T_j:	125 °C	———
R_{gon} =	4	Ω		150 °C	– – –

figure 8. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



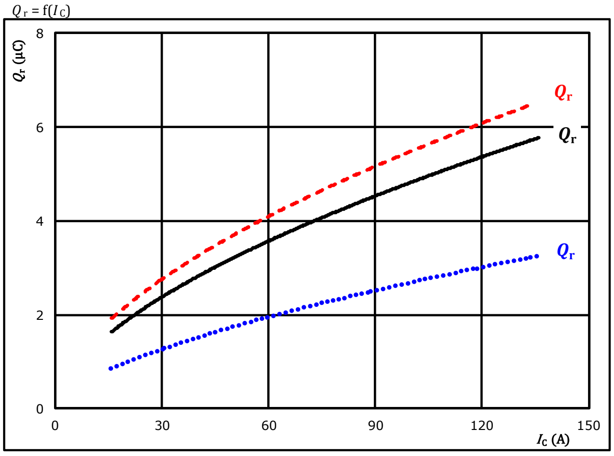
At					
V_{CE} =	350	V		25 °C	•••••••••••••
V_{GE} =	±15	V	T_j:	125 °C	———
I_C =	76	A		150 °C	– – –

Low Boost Switching Characteristics

figure 9. FWD

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$

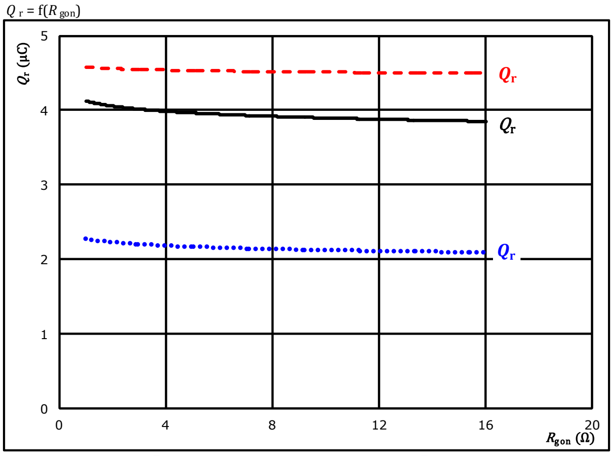


At	V_{CE} =	350	V	T_j:	25 °C
	V_{GE} =	±15	V		125 °C
	R_{gon} =	4	Ω		150 °C

figure 10. FWD

Typical recovered charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$

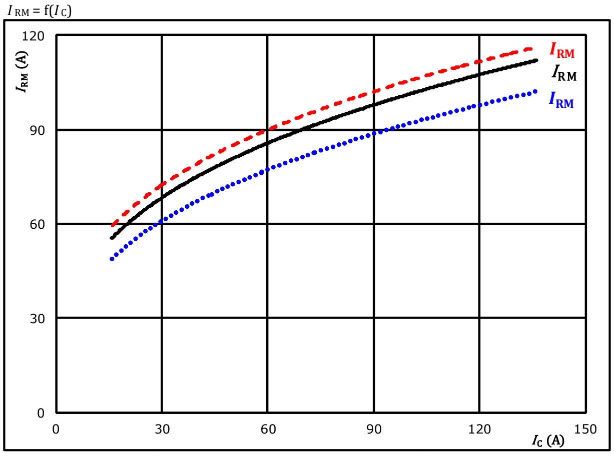


At	V_{CE} =	350	V	T_j:	25 °C
	V_{GE} =	±15	V		125 °C
	I_C =	76	A		150 °C

figure 11. FWD

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$

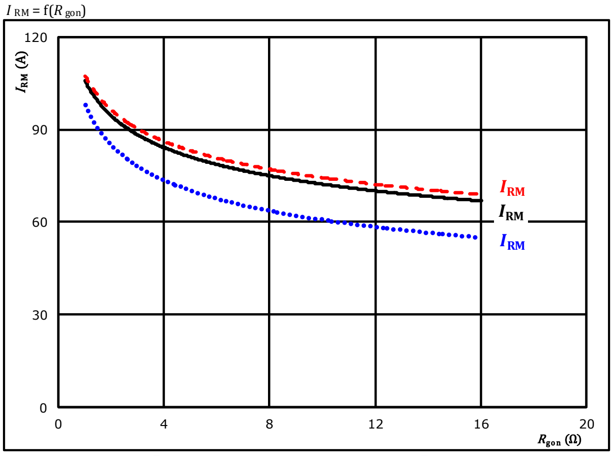


At	V_{CE}:	350	V	T_j:	25 °C
	V_{GE} =	±15	V		125 °C
	R_{gon} =	4	Ω		150 °C

figure 12. FWD

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



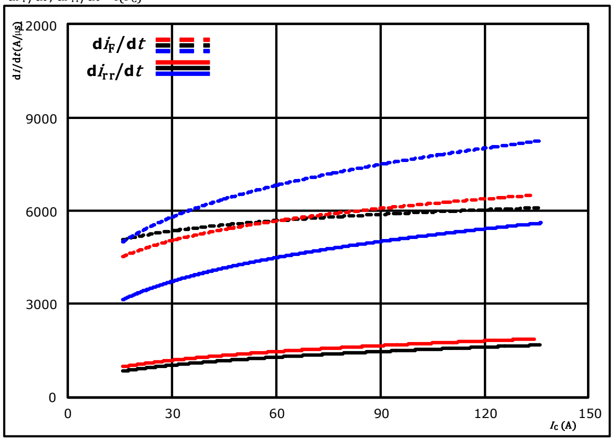
At	V_{CE} =	350	V	T_j:	25 °C
	V_{GE} =	±15	V		125 °C
	I_C =	76	A		150 °C

Low Boost Switching Characteristics

figure 13. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, di_{rr}/dt = f(I_C)

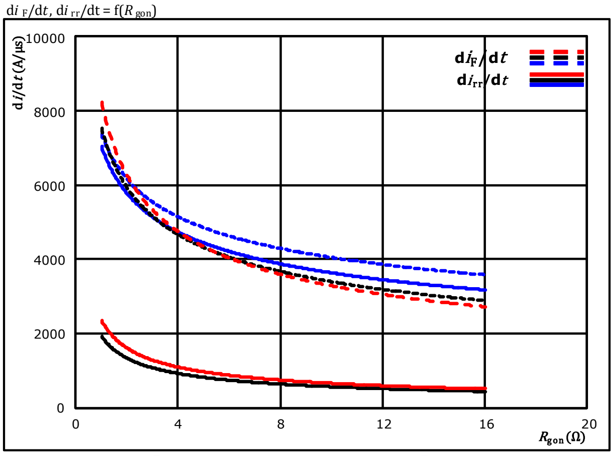


At						
V_{CE} =	350	V	T_j:	25	°C	dotted
V_{GE} =	±15	V		125	°C	solid
R_{gon} =	4	Ω		150	°C	dashed

figure 14. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

di_F/dt, di_{rr}/dt = f(R_{gon})

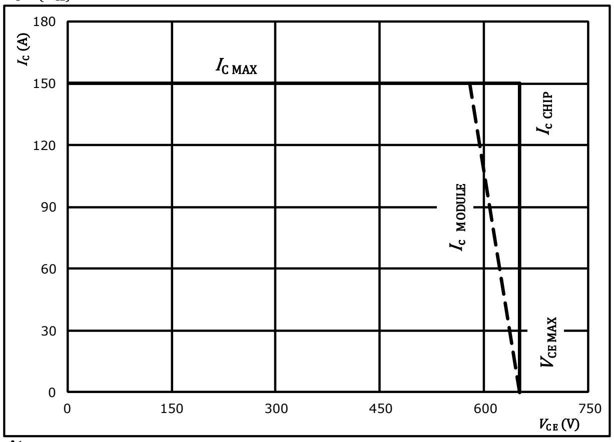


At						
V_{CE} =	350	V	T_j:	25	°C	dotted
V_{GE} =	±15	V		125	°C	solid
I_C =	76	A		150	°C	dashed

figure 15. **IGBT**

Reverse bias safe operating area

I_C = f(V_{CE})



At		
T_j =	175	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

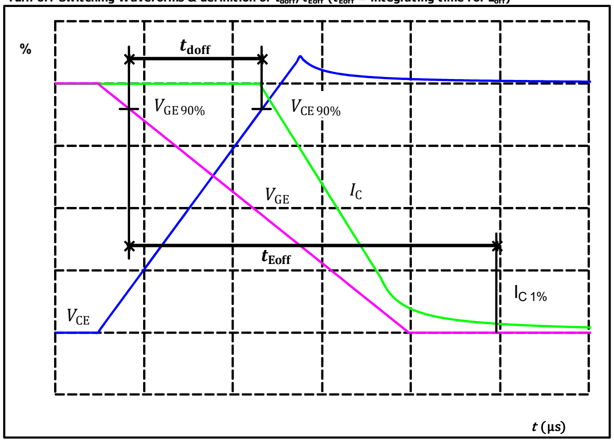
Low Boost Switching Definitions

General conditions

T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

figure 1. IGBT

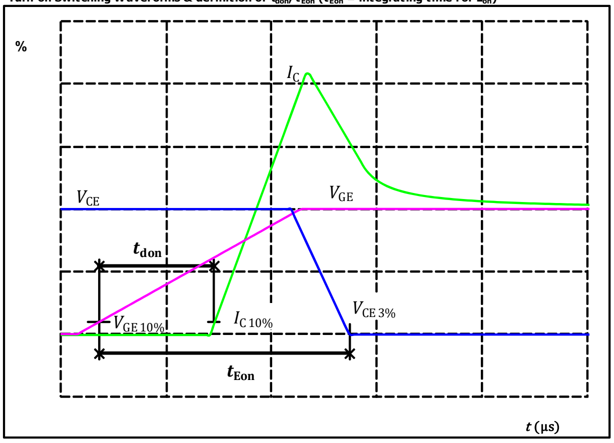
Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff} (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_{doff} =	106	ns

figure 2. IGBT

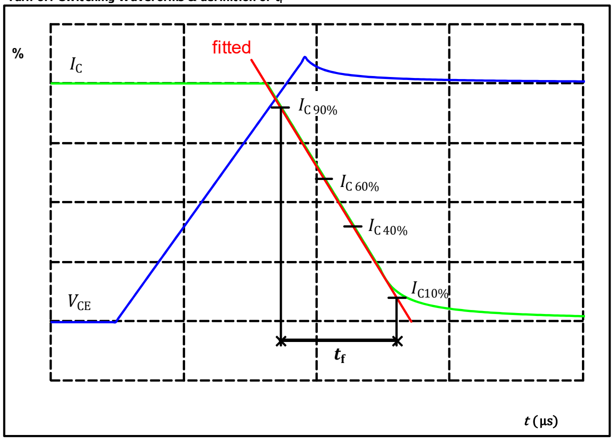
Turn-on Switching Waveforms & definition of t_{don}, t_{Eon} (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_{don} =	62	ns

figure 3. IGBT

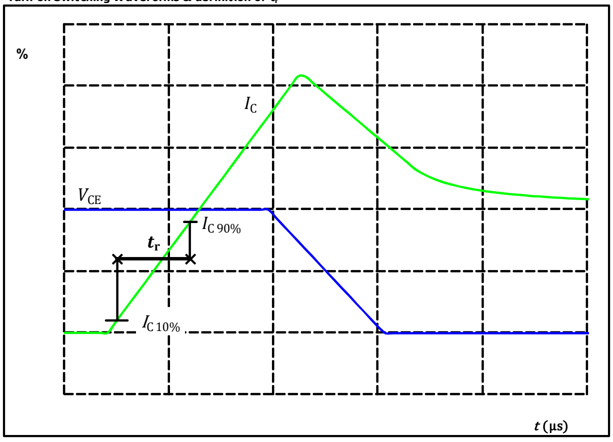
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_f =	17	ns

figure 4. IGBT

Turn-on Switching Waveforms & definition of t_r

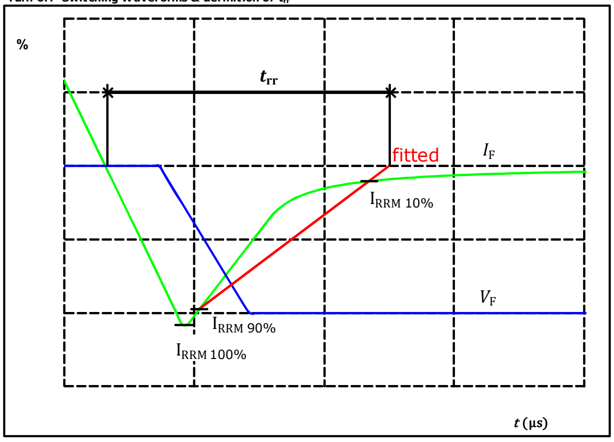


$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_r =	10	ns

Low Boost Switching Characteristics

figure 5. **FWD**

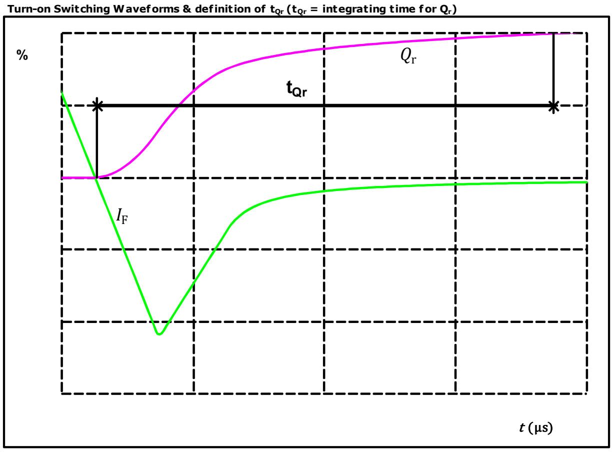
Turn-off Switching Waveforms & definition of t_{rr}



V_F (100%) =	350	V
I_F (100%) =	76	A
I_{RRM} (100%) =	93	A
t_{rr} =	100	ns

figure 6. **FWD**

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



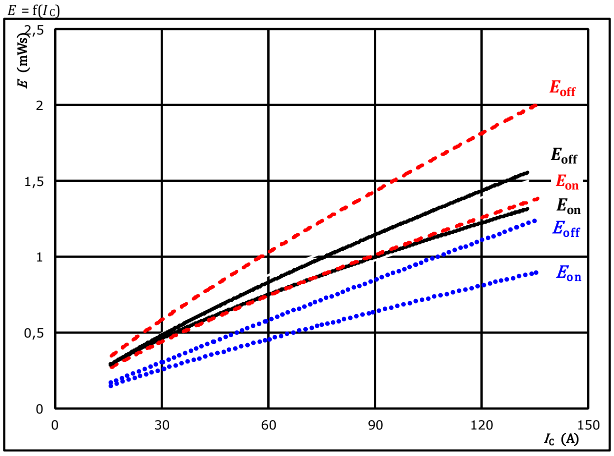
I_F (100%) =	76	A
Q_r (100%) =	4,08	µC

High Boost Switching Characteristics

figure 1. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



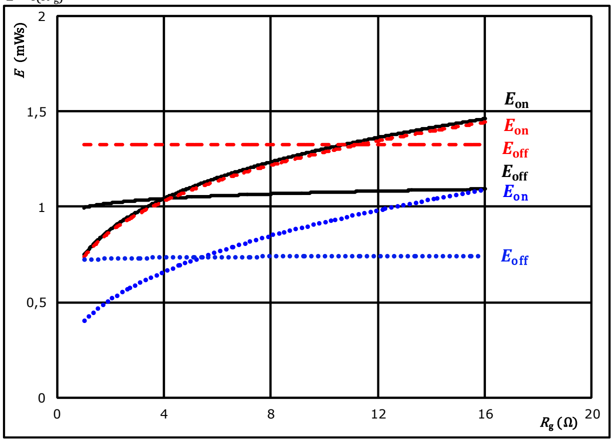
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	4	Ω		150 °C
R_{goff} =	4	Ω		

figure 2. **IGBT**

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



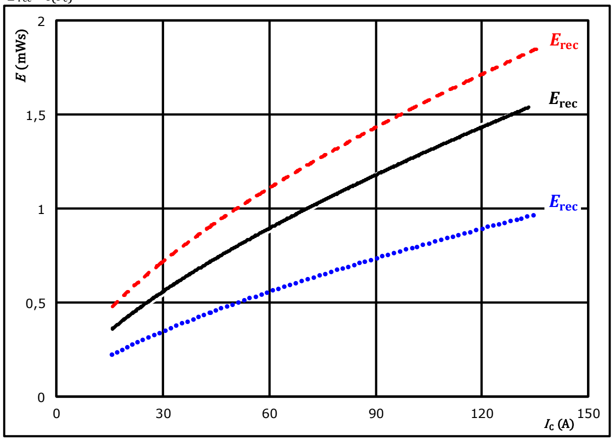
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	76	A		150 °C

figure 3. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_c)$



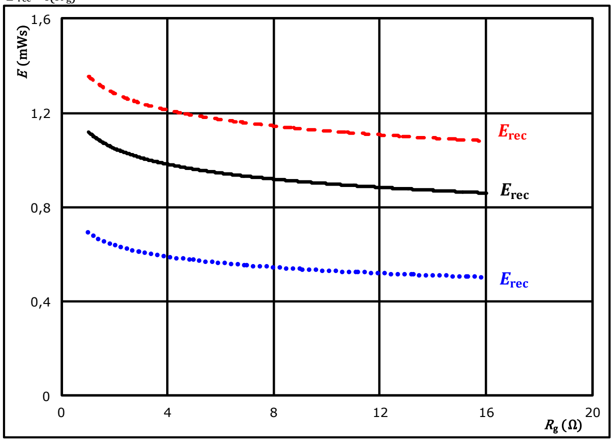
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	4	Ω		150 °C

figure 4. **FWD**

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

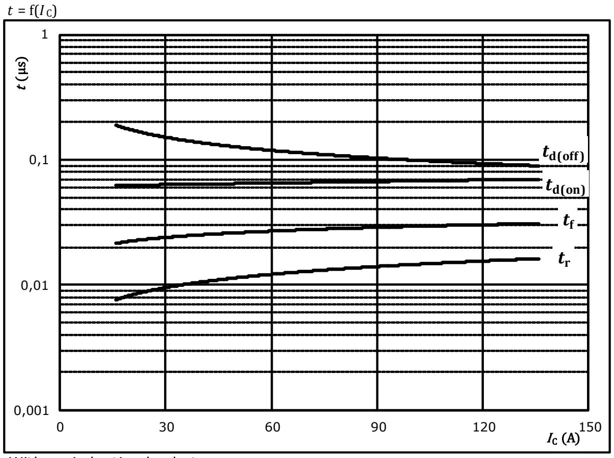
V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	76	A		150 °C

High Boost Switching Characteristics

figure 5. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



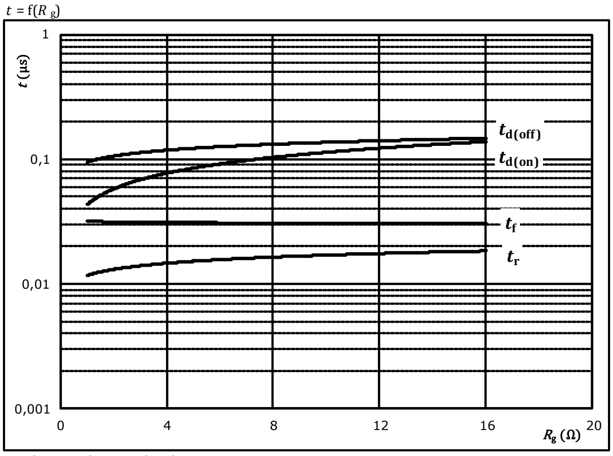
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

figure 6. **IGBT**

Typical switching times as a function of gate resistor

$t = f(R_g)$



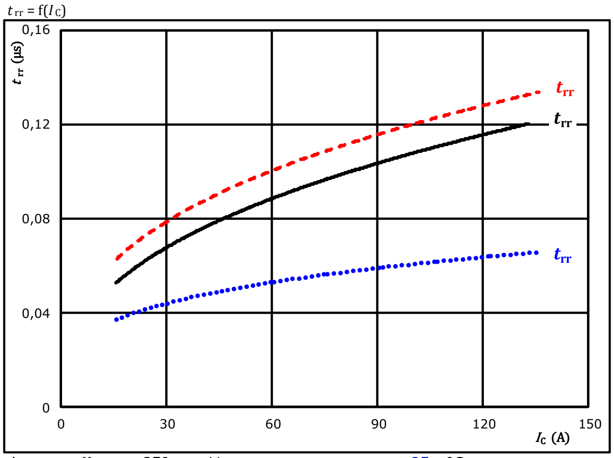
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	76	A

figure 7. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$

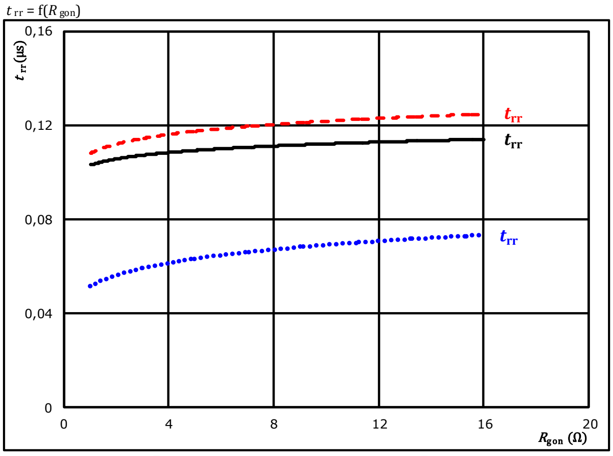


At V_{CE} =	350	V		25	°C
V_{GE} =	±15	V	T_j:	125	°C
R_{gon} =	4	Ω		150	°C

figure 8. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



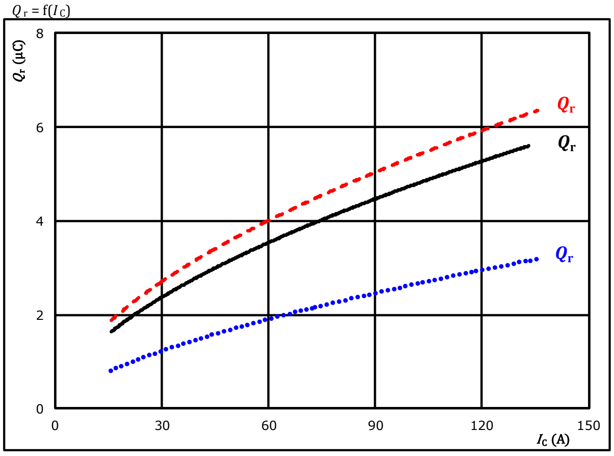
At V_{CE} =	350	V		25	°C
V_{GE} =	±15	V	T_j:	125	°C
I_C =	76	A		150	°C

High Boost Switching Characteristics

figure 9. **FWD**

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$

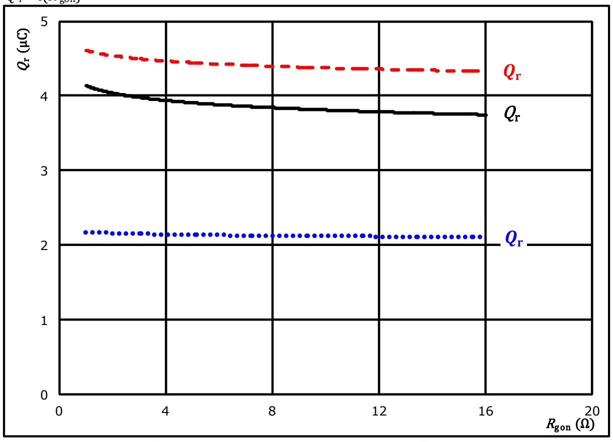


At						
V_{CE} =	350	V		25	°C	···········
V_{GE} =	±15	V	T_j:	125	°C	———
R_{gon} =	4	Ω		150	°C	– – –

figure 10. **FWD**

Typical recovered charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$

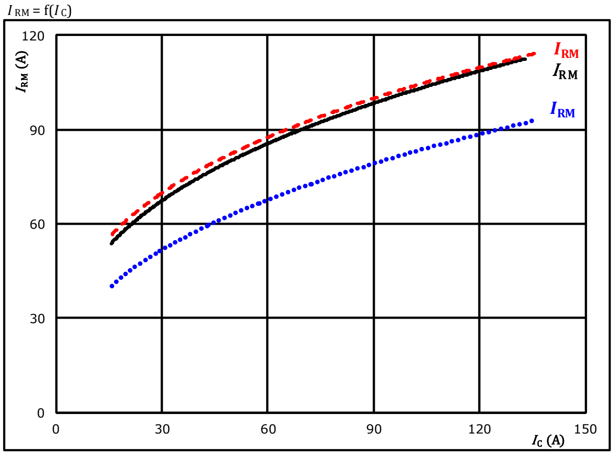


At						
V_{CE}=	350	V		25	°C	···········
V_{GE} =	±15	V	T_j:	125	°C	———
I_C=	76	A		150	°C	– – –

figure 11. **FWD**

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$

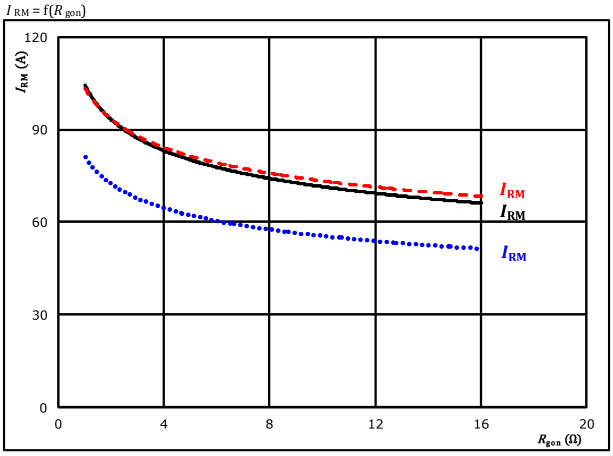


At						
V_{CE}:	350	V		25	°C	···········
V_{GE} =	±15	V	T_j:	125	°C	———
R_{gon} =	4	Ω		150	°C	– – –

figure 12. **FWD**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



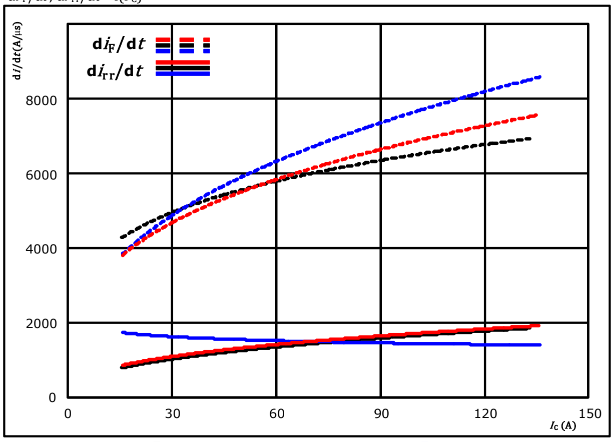
At						
V_{CE} =	350	V		25	°C	···········
V_{GE} =	±15	V	T_j:	125	°C	———
I_C =	76	A		150	°C	– – –

High Boost Switching Characteristics

figure 13. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, $di_{rr}/dt = f(I_C)$

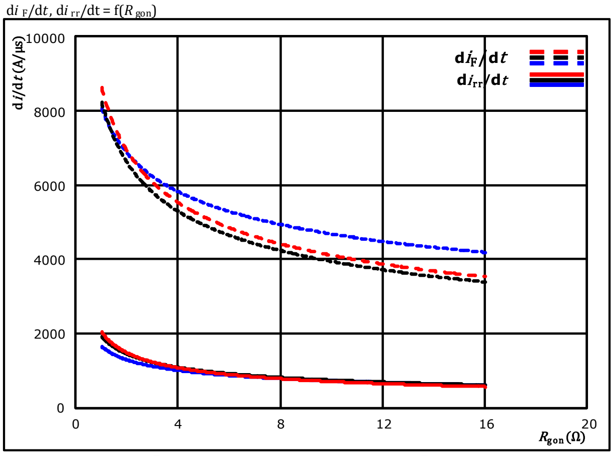


At					
V_{CE} =	350	V	T_j:	25 °C	dotted
V_{GE} =	±15	V		125 °C	solid
R_{gon} =	4	Ω		150 °C	dashed

figure 14. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

di_F/dt, $di_{rr}/dt = f(R_{gon})$

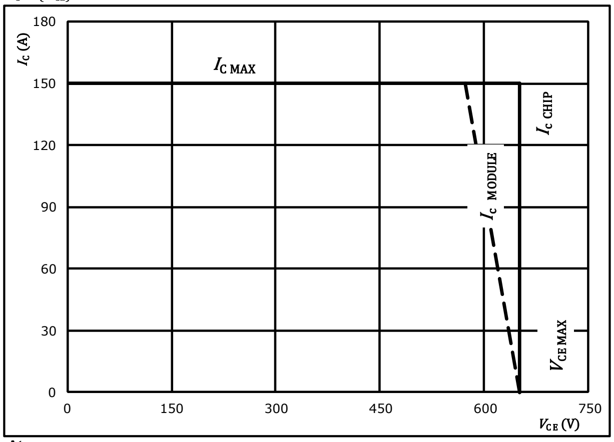


At					
V_{CE} =	350	V	T_j:	25 °C	dotted
V_{GE} =	±15	V		125 °C	solid
I_C =	76	A		150 °C	dashed

figure 15. **IGBT**

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

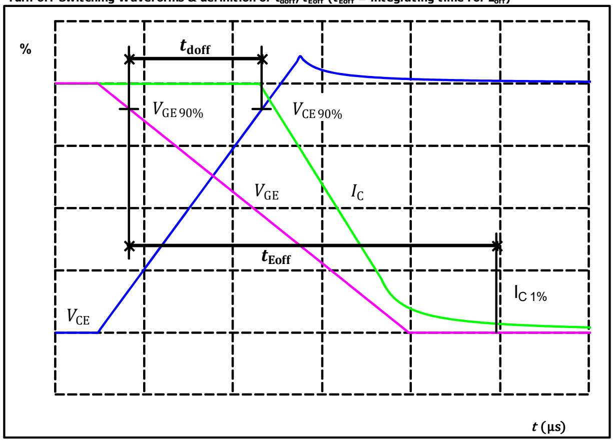
T_j =	175	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

High Boost Switching Definitions

General conditions		
T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

figure 1. IGBT

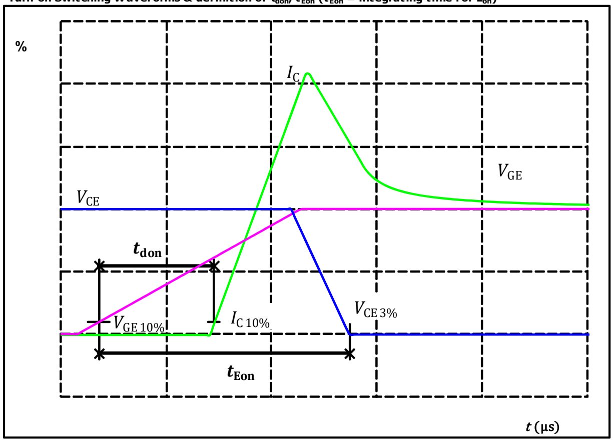
Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff} (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_{doff} =	105	ns

figure 2. IGBT

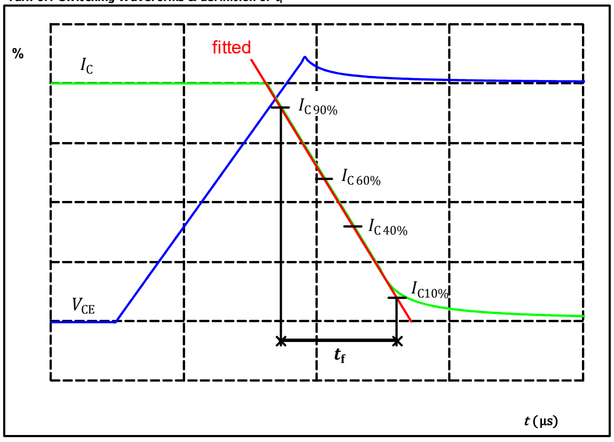
Turn-on Switching Waveforms & definition of t_{don}, t_{Eon} (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_{don} =	64	ns

figure 3. IGBT

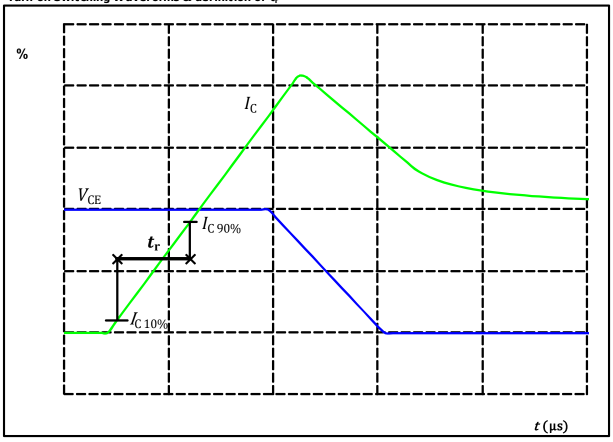
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_f =	21	ns

figure 4. IGBT

Turn-on Switching Waveforms & definition of t_r

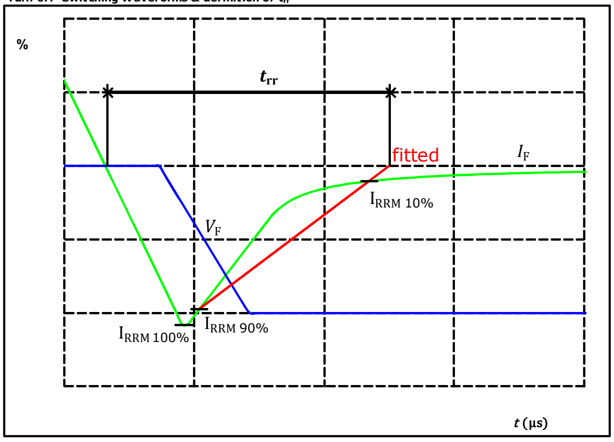


$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_r =	11	ns

High Boost Switching Characteristics

figure 5. **FWD**

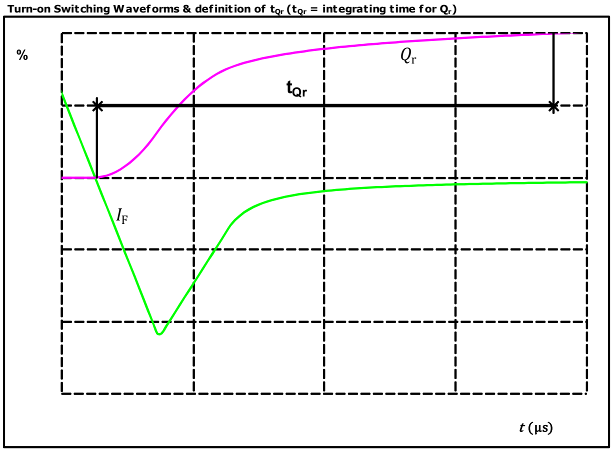
Turn-off Switching Waveforms & definition of t_{rr}



V_F (100%) =	350	V
I_F (100%) =	76	A
I_{RRM} (100%) =	92	A
t_{rr} =	105	ns

figure 6. **FWD**

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



I_F (100%) =	76	A
Q_r (100%) =	4,02	μC

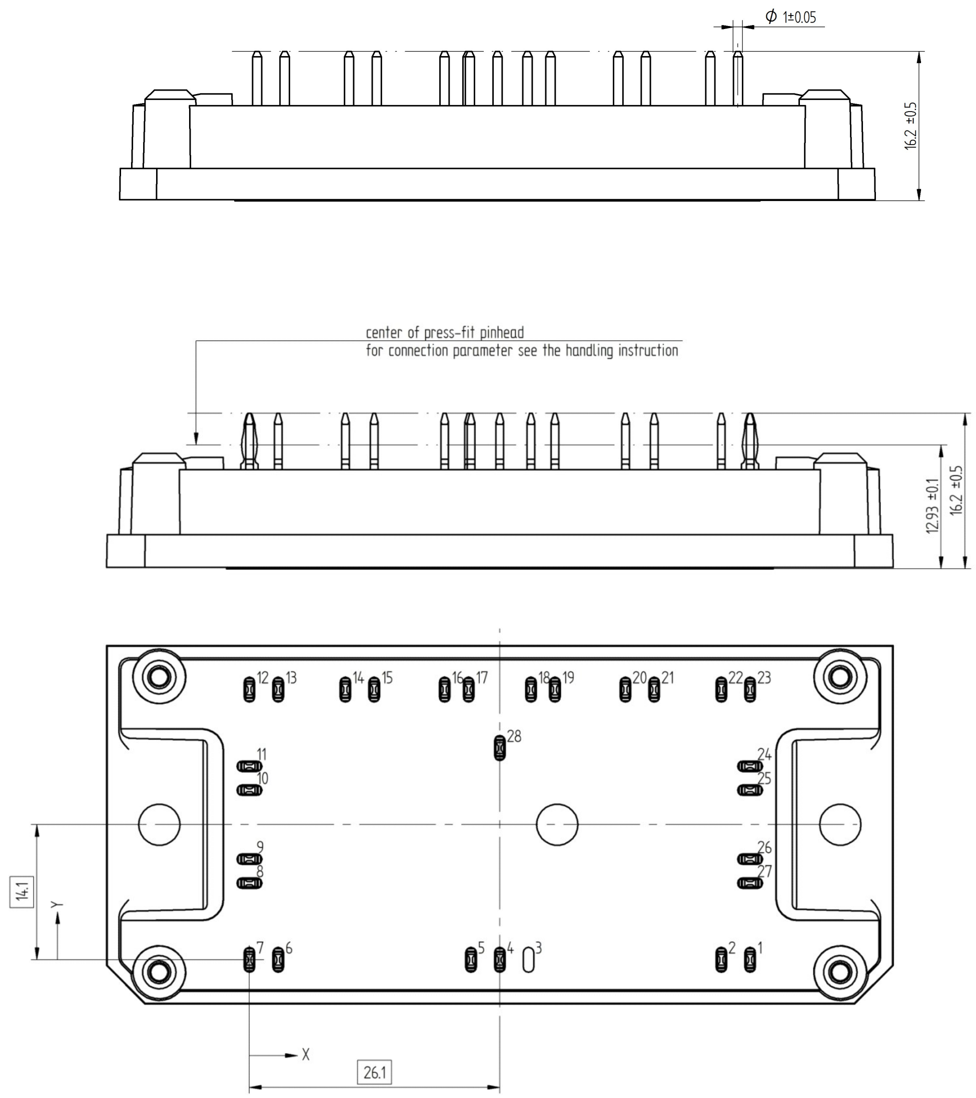
Ordering Code & Marking

Version	Ordering Code
without thermal paste with solder pins	10-FY07HVA075S502-L985F18
without thermal paste with pressfit-pins	10-PY07HVA075S502-L985F18Y

Text	Name		Date code	UL & VIN	Lot	Serial
	NN-NNNNNNNNNNNNNN-TTTTTTVV		WWYY	UL VIN	LLLLL	SSSS
Datamatrix	Type&Ver	Lot number	Serial	Date code		
	TTTTTTTVV	LLLLL	SSSS	WWYY		

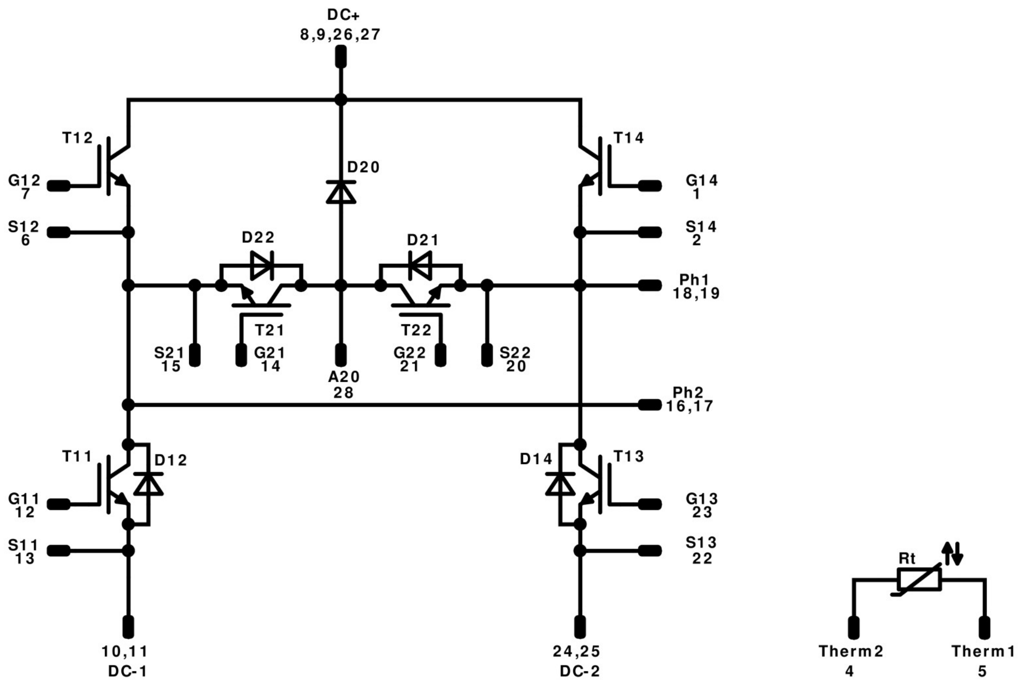
Outline

Pin table			
Pin	X	Y	Function
1	52,2	0	G14
2	49,2	0	S14
3	Not assembled		
4	26,1	0	Therm2
5	23,1	0	Therm1
6	3	0	S12
7	0	0	G12
8	0	8	DC+
9	0	10,5	DC+
10	0	17,7	DC-1
11	0	20,2	DC-1
12	0	28,2	G11
13	3	28,2	S11
14	10	28,2	G21
15	13	28,2	S21
16	20,35	28,2	Ph2
17	22,85	28,2	Ph2
18	29,35	28,2	Ph1
19	31,85	28,2	Ph1
20	39,2	28,2	S22
21	42,2	28,2	G22
22	49,2	28,2	S13
23	52,2	28,2	G13
24	52,2	20,2	DC-2
25	52,2	17,7	DC-2
26	52,2	10,5	DC+
27	52,2	8	DC+
28	26,1	22,1	A20



Tolerance of pinpositions: ±0.5mm at the end of pins
Dimension of coordinate axis is only offset without tolerance

Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T11, T13	IGBT	650 V	75 A	Low Buck Switch	
T12, T14	IGBT	650 V	75 A	High Buck Switch	
D21, D22	FWD	650 V	50 A	Buck Diode	
T21, T22	IGBT	650 V	75 A	Boost Switch	
D12, D14	FWD	650 V	50 A	Low Boost Diode	
D20	FWD	650 V	50 A	High Boost Diode	
Rt	NTC			Thermistor	

Vincotech

10-FY07HVA075S502-L985F18
10-PY07HVA075S502-L985F18Y

datasheet

Packaging instruction				
Standard packaging quantity (SPQ) 100	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for *flow* 1 packages see vincotech.com website.

Package data
Package data for *flow* 1 packages see vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website.

Document No.:	Date:	Modification:	Pages
10-PY07HVA075S502-L985F18Y-D4-14	12 Mar. 2019	Correction of I_c/I_f values	2
10-xY07HVA075S502-L985F18x-D5-14	29 May. 2020	Solder pin version added	All